1. Moiré Interferometry

The basic concepts and practice of moiré interferometry are reviewed. Moiré interferometry provides contour maps of in-plane displacement fields with high sensitivity and high spatial resolution. It has matured as an invaluable tool for engineering analyses, proved by many industrial and scientific applications. With the typical reference grating frequency of 2400 lines/mm, the contour interval is 0.417 µm displacement per fringe order. For microscopic moiré interferometry, sensitivity in the nanometer range has been achieved. Reliable normal strains and shear strains are extracted from the displacement data for bodies under mechanical, thermal and environmental loading.

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This section introduces basic concepts of moiré interferometry and their evolution, leading to the current practice. Moiré interferometry has become an important tool in industrial, research and academic organizations. The tool is used to measure tiny deformations of solid bodies, caused by mechanical forces, temperature changes, or other environmental changes. It is the in-plane deformations that are measured, namely the $U$ and $V$ components of displacement that are parallel to the surface of the body. These are the displacements from which the induced strains and stresses are determined.

Moiré interferometry has been applied for studies of composite materials, polycrystalline materials, layered materials, piezoelectric materials, fracture mechanics, biomechanics, structural elements, and structural joints. It is practiced extensively in the microelectronics industry to measure thermally induced deformation of electronic packages.

For in-plane displacement measurements, the technology has evolved beautifully from low-sensitivity geometric moiré to the powerful capabilities of moiré interferometry. Moiré measurements are performed routinely in the interferometric domain with fringes representing subwavelength displacements per contour. Since moiré responds only to geometric changes, it is equally effective for elastic, viscoelastic, and plastic deformations, for isotropic, orthotropic and anisotropic materials, and for mechanical, thermal, and dynamic loadings.

The history of moiré interferometry is described in [1.1]; in that paper, “A Historical Review of Moiré Interferometry,” Walker recounted the pioneering developments in Japan, which predated accomplishments in the Western world by several years, but was not widely known in the West. He outlined work by Sciamarella and by Post and their students in the U.S., and by several investigators in Europe – especially the outstanding work...
Fig. 1.1 Demonstration of moiré interferometry at 97.6% of the theoretical limit of sensitivity. $f = 4000$ lines/mm. The patterns are from the shaded regions. Excellent fringe resolution was evident in the full 76×51 mm specimen grating area at Strathclyde University by McKelvie, Walker and their colleagues. Moiré interferometry has matured through worldwide efforts.

Work at Virginia Tech began in 1979, where we were responsible for numerous advances. We felt confidence in the power of the method in 1981 when Weissman [1.2] produced the fringe pattern shown in Fig. 1.1. It depicts the vertical displacement field surrounding a hole in a plate loaded in tension. It demonstrated the moiré effect at 4000 lines/mm. It demonstrated moiré interferometry at 97.6% of its theoretical limit of sensitivity. It demonstrated the V deformation field with a huge number of fringes, or displacement contours, and the fringes had superb visibility.

The instrumentation was simple, as illustrated in Fig. 1.2. A phase grating of 2000 lines/mm was formed on the specimen, and it deformed together with the specimen grating. The deformed specimen grating interacts with the virtual reference grating to form the moiré pattern. The phenomenon is analogous to geometric moiré.
specimen as the specimen was loaded. A Lloyd’s mirror arrangement created a 4000 lines/mm interference fringe pattern in the same space, and that pattern acted as the reference grating. It is called a virtual reference grating. (It was not a real reference grating of the sort used in geometric moiré, but instead, it was an interference pattern formed in space that functioned as a reference grating.) The specimen grating and the reference grating interacted to form the moiré fringes of Fig. 1.1. The scheme is illustrated in Fig. 1.3, where the two coherent beams from the Lloyd’s mirror arrangement interfere to form the virtual reference grating of frequency $f_w$, which interacts with the specimen grating of frequency $f_s$ to create the moiré pattern.

Stepping back, the transition from geometric moiré to moiré interferometry evolved largely in the 1970s. Whereas only low frequency gratings could be applied to specimens, high frequency reference gratings could be used, together with an optical filtering arrangement, to produce moiré fringe multiplication. The fringe multiplication factor, $\beta$, was the ratio of grating frequencies, and the sensitivity corresponded to the pitch of the high frequency reference grating; the sensitivity became $\beta$ times that of standard geometric moiré, where specimen and reference gratings of equal frequencies are used. Multiplication by $\beta = 60$ was documented [1.3], but at a substantial sacrifice of the efficiency of light utilization.

Then it was realized that light diffracted by a real reference grating ($BB$) creates a virtual reference grating, as illustrated in Fig. 1.4a. It is the virtual grating that interacts with the specimen grating to create the moiré pattern. Consequently, it was realized that the interference pattern produced by the intersection of any two mutually coherent beams (Fig. 1.4b) can act as a virtual reference grating and it can replace the real reference grating. Thus, in Fig. 1.2 the direct and the reflected beams, intersecting at angle $2\alpha$, provided the virtual reference grating.

(An important equivalency principle is acting here: interference of two beams creates a virtual grating of frequency $f$; a real grating of frequency $f$ creates the same two beams [1.4]. In fact, this equivalency is also the basis of holography.)

It became clear that phase gratings (ridges and furrows) could be used as well as the amplitude gratings (bars and spaces) of geometric moiré. Several innovations evolved to link the techniques of the 1970s to the present. A significant factor was the practical availability of the laser, which provided very high monochromatic purity and allowed high contrast two-beam optical interference even when the beams traveled substantially unequal path lengths. The laser led to a practical technique to produce high frequency phase-type specimen gratings.

For this process, a setup with a beam-splitter and mirrors formed the two mutually coherent beams of Fig. 1.4b. A plate with a photosensitive coating – photographic emulsion or photoresist – was inserted to record the virtual grating. When developed, the plate exhibited the ridges and furrows of a phase grating, in exact registration with the bands of constructive and destructive interference of the virtual grating. Subsequently, the phase grating was replicated on the specimen by known techniques, using silicone rubber, epoxy, or various plastics to reproduce the array of ridges and furrows on the specimen.

Specimen gratings of very high frequency could be made, so the need for high fringe multiplication factors vanished. The moiré interferometry technique described here is actually moiré fringe multiplication with a multiplication factor of two. It utilizes the first-order diffractions from the specimen grating instead of high diffraction orders. The choice circumvents
the inefficient light utilization and increased optical noise associated with higher orders, while maintaining the advantage of viewing the specimen at normal incidence.

Numerous refinements were introduced in the 1980s. Cross-line specimen gratings, together with 4-beam moiré interferometers became standard practice; this eliminated the classical uncertainty of shear measurements and enabled accurate determination of both shear and normal strains. The use of carrier fringes became common. Practical techniques for measurement of thermal strains were developed. Achromatic moiré interferometers were developed. Microscopic moiré interferometry was introduced.

In the 1990s, CCD cameras became popular for recording the fringe patterns. This led to phase stepping and automated full-field strain maps. Phase stepping proved to be an important asset for cases where fringes were sparse, because phase stepping increases the quantity of data for analysis. (For typical applications, where the fringe data is abundant, phase stepping is superfluous and sometimes counterproductive.)

A very important milestone occurred in the 1990s. IBM Corporation discovered the value of moiré interferometry for experimental analysis of thermal deformation of microelectronic devices. It was used to measure – sometimes to discover – the deformation behavior of their small complex structures, and to guide and verify their numerical analyses. Since then, moiré interferometry has propagated extensively in the electronic packaging industry, to become a standard tool for experimental analysis.

Item 1 in the Bibliography provides comprehensive coverage of the theory and practice, and diverse applications of moiré interferometry in one volume. The present chapter is intended to review the basic concepts and qualities in lesser detail, but sufficient for understanding the practice and for recognizing the power and place of moiré interferometry as a tool of experimental solid mechanics.

### 1.1 Current Practice

Moiré interferometry was developed to measure the in-plane displacements of essentially flat surfaces. If demanded, it can cope with curved surfaces, but with greater effort; Fig. 1.15, to be addressed later, is an example.

Two displacement fields fully define the state of engineering strain along the surface. Normally two orthogonal displacement fields are recorded: the \( U \) and \( V \) fields. They represent \( x \)- and \( y \)-components of displacement at every point in the field. The data are received as moiré fringe patterns, where the fringes are contours of constant \( U \) or \( V \) displacements. Fringe orders are given the symbols \( N_U \) and \( N_V \), where \( N_U = fU \) and \( N_V = fV \). The fringe orders are proportional to the displacements, and the constant of proportionality is the frequency, \( f \), of the (virtual) reference grating. Of course, we can write the relationships in terms of the pitch \( g \) of the reference grating, since \( f = 1/g \).

#### 1.1.1 Specimen Gratings

Typically, the virtual reference grating frequency is \( f = 2400 \text{ lines/mm} \) (60 960 lines/in); the moiré interferometer projects this grating onto the specimen. The specimen grating is a cross-line phase grating with 1200 lines/mm in both the \( x \)- and \( y \)-directions. It is usually formed on the specimen by replication from a mold, which is itself a cross-line grating. A greatly enlarged view is shown in Fig. 1.5a, illustrating the orthogonal array of hills that comprise the cross-line grating.

The replication method of Fig. 1.5b is used for diverse applications that involve larger regions of interest, e.g., larger than one square cm. The mold is prepared with a reflective metallic film, usually evaporated aluminium. A liquid adhesive, usually an epoxy, is squeezed into a thin layer between the specimen and mold. They are separated when the adhesive solidifies. The weakest interface is between the metallic film and the underlying mold, so the reflective metallic film is transferred to the specimen together with the hills and valleys of the grating. The total grating thickness is usually about 25 \( \mu \text{m} \).

The technique of Fig. 1.5c is used for small specimens of complex geometry, like those encountered in electronic packaging tests. In this case, the specimen is prepared with a smooth, flat surface. A very thin layer of low viscosity adhesive is spread on the mold by the drag method and the specimen is pressed into the adhesive. Surface tension draws the thin adhesive away from the edges of the specimen; therefore, no cleaning operation is required to remove the excess adhesive. With this
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1.1 Current Practice

1.1.2 Optical Systems

The generic optical system is illustrated in Fig. 1.6. As in Fig. 1.3, two coherent, collimated beams marked \( B_1 \)

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**Fig. 1.5** (a) 1200 lines/mm cross-line specimen grating. (b) Replication procedure for typical specimen gratings. (c) Procedure for small specimens of complex geometry

procedure, the grating thickness is usually about 2 \( \mu m \). Again, the result is a thin, compliant, reflective cross-line grating, which deforms together with the underlying specimen.
and \( B_2 \) create a virtual reference grating with its lines perpendicular to the \( x \)-direction. They interact with the corresponding array of lines on the specimen grating to create the \( N_x \) fringe pattern, depicting the \( x \)-component of displacement. The fringe pattern is recorded by the camera, which is focused on the specimen. Typically, it is a digital CCD camera. Then beams \( B_3 \) and \( B_4 \) are used to record the \( N_y \) pattern. The virtual reference grating frequency is usually 2400 lines/mm. For light in the visible wavelength range, \( \alpha \) is near 45°. The contour interval for the fringe pattern is \( 1/f \), i.e., a displacement of 0.417 \( \mu \text{m} \) per fringe order.

Numerous different optical systems can be designed to provide the essential elements of Fig. 1.6. A few systems are illustrated in [1.4]. Two-beam systems have been used for special applications. For strain and stress analysis, the 4-beam optical system offers a vital advantage: shear strains can be extracted with the same accuracy as normal strains.

Achromatic optical systems have also been devised, and Fig. 1.7 is an example [1.4]. A temporally incoherent light source can be used. With this arrangement, the angle of diffraction, \( \alpha \), at the upper grating changes in exact harmony with the wavelength \( \lambda \) to maintain a fixed frequency \( f \) of the virtual reference grating. The upper grating is called a compensator grating, since it compensates for variations of the wavelength. Whereas monochromatic purity is not needed, spatial coherence remains a requirement.

1.1.3 The Equations

The pertinent equations are these:

- For optical interference of 2 beams (Fig. 1.4b)

\[
F = \frac{2}{\lambda} \sin \theta, \tag{1.1}
\]

where \( F \) is the fringe frequency (fringes/mm) in the region of intersection, \( \lambda \) is the wavelength, and \( \theta \) is the half-angle of intersection.

- For the moiré interferometer

\[
\sin \alpha = \frac{\lambda f}{2}, \quad f = 2f_s \tag{1.2}
\]

where \( f \) and \( f_s \) is the frequency of the virtual reference grating and the specimen grating, respectively.

- For the displacements at each point in the field

\[
U = \frac{1}{f} N_x; \quad V = \frac{1}{f} N_y, \tag{1.3}
\]

where \( U \) and \( V \) are displacements in the \( x \)- and \( y \)-directions, respectively.
For the strains at each point
\[ \varepsilon_x = \frac{\partial U}{\partial x} = \frac{1}{f} \left( \frac{\partial N_x}{\partial x} \right), \]
\[ \varepsilon_y = \frac{\partial V}{\partial y} = \frac{1}{f} \left( \frac{\partial N_x}{\partial y} \right), \]
(1.4)
\[ \gamma_{xy} = \frac{\partial U}{\partial y} + \frac{\partial V}{\partial x} = \frac{1}{f} \left( \frac{\partial N_x}{\partial y} + \frac{\partial N_y}{\partial x} \right), \]
(1.5)
where \( \varepsilon \) and \( \gamma \) are normal and shear strains, respectively. Thus, the strains are determined by the rate of change of fringe orders in the patterns, or the fringe gradient surrounding each point.

For fringe gradients
\[ \frac{\partial N_x}{\partial x} \approx \frac{\Delta N_x}{\Delta x}, \text{ etc.} \]
(1.6)
The derivatives are usually approximated by their finite increments, i.e., the change of fringe order that occurs in a finite distance \( \Delta x \).

For the stresses
Stresses are determined from the strains, using the stress-strain relationships (or the constitutive equations) for the specimen material.

### 1.1.4 Fringe Counting

The rules of topography of continuous surfaces govern the order of fringes [1.5]. Fringes of unequal orders cannot intersect. The fringe order at any point is unique, independent of the path of the fringe count used to reach the point.

The location of a zero-order fringe in a moiré pattern can be selected arbitrarily. Any fringe – black, white or gray – can be assigned as the zero order fringe. This is because rigid-body translations are not important in deformation analysis. Absolute displacement information is not required and relative displacements can be determined using an arbitrary datum. In Fig. 1.8, the zero fringe is assigned in the lower left region of the specimen. Of course, at every point along this continuous fringe, \( N_x = 0 \).

Figure 1.8 shows the deformation of a tensile coupon cut from a stainless steel plate in the region of a weld. Cracks appear in the weld, but along the left edge of the specimen, the material is continuous. Since the strain is tensile, or positive, the fringe orders along the left edge increase monotonically in the \(+y\)-direction, as shown. Then the fringe orders can be assigned at every point in the field by following continuous fringes across the field. Fringe orders along the right edges were assigned accordingly.

Where a crack is present, the \( V \) displacements are different along the upper and lower lips of the crack. This accounts for the crack opening that results from the tensile load. For example, at the right edge the fringe order changes from \( N_y = 3 \) to \( N_y = 10 \), indicating a crack-opening displacement of 7 fringe orders, or 2.9 \( \mu \)m (115 \( \mu \)in).

Clues derived from known loading conditions and known specimen geometry are often sufficient to establish the sign of the fringe gradient at every point, i.e., to establish whether the fringe order is increasing or decreasing as the count progresses from one fringe to the neighboring fringe. Occasionally the clues might not be sufficient, but there is always a simple experimental way to determine the sign of the fringe gradient.

If during the experiment, the specimen is moved gently in the \(+x\)-direction, the fringe order \( N_x \) at every point increases. This means that the fringes all move toward the direction of lower-order fringes. Thus, if the \( N_x \) fringes move in the negative \( x \)-direction, the gradient \( \partial N_x / \partial x \) is positive. The argument is the same for the \( y \)-direction. A convenient alternative is available if the moiré interferometer is equipped for phase stepping (fringe shifting). The investigator can watch the pattern while the fringes are shifted. Again, the fringes...
move toward lower fringe orders when the phase is increased. Thus, the sign of the fringe gradients is readily determined at any point.

1.1.5 Strain Analysis

Strains are determined from the two displacement fields by the relationships for engineering strain, (1.4) and (1.5). In principle, the exact differential can be extracted at any point by plotting a curve of fringe orders along a line through the point and measuring the slope of the curve at the point. Often, however, the finite increment approximation is sufficient, whereby (as an example) \( \partial \Delta N_x / \partial x \) is taken to be equal to \( \Delta N_x / \Delta x \). In that case, strain is determined by measuring \( \Delta x \), the distance between neighboring fringes, in the immediate neighborhood of the point of interest.

Shear strains are determined as readily as normal strains. Numerous examples of fringe counting and strain analysis are given in [1.4]. In nearly all cases of strain analysis, the strains are sought at specific points (e.g., where the fringes are most closely spaced, indicating strain maxima), or along specific lines. Manual methods, and computer-assisted methods are most practical for such cases.

1.2 Important Concepts

1.2.1 Physical Description

The description offered with Fig. 1.3 is a casual explanation based upon the analogy to geometric moiré. Nevertheless, it is effective. The rigorous analysis of moiré interferometry [1.4], based on diffraction and optical interference, shows that the fringe order/displacement relationship is identical for moiré interferometry and geometric moiré. The simple, intuitive procedures to extract data from geometric moiré patterns apply also to moiré interferometry patterns.

This is important for our colleagues who might practice moiré interferometry, but specialize in diverse aspects of engineering and materials science, as distinct from specialists in optical techniques.

For our colleagues in photomechanics, the physical description illustrated in Fig. 1.9 is more satisfying. Before loads are applied to the specimen, the grating on its surface has a uniform frequency of \( f_s \). The incident beam 1 is diffracted such that its first order emerges normal to the specimen, with wave front \( w'_1 \). This requires that \( \sin \alpha \equiv \lambda f_s \). Similarly, beam 2 is diffracted to form emergent wave front \( w'_2 \). For these initial conditions, the emergent beams have parallel wave fronts and they interfere to create a null field, i.e., a uniform intensity or the infinite fringe.

Incidentally, we note from (1.1) that when two beams intersect with this half-angle \( \alpha \), they generate interference fringes of frequency \( f \), where \( f \equiv 2 f_s \). Thus, the frequency of the virtual reference grating of Fig. 1.3 is twice the initial frequency of the specimen grating. This is the condition that provides normal viewing, without distortion of the image.

For a complex specimen, the specimen grating deforms nonuniformly when loads are applied. The grating pitch and orientation vary as continuous functions along the specimen. Consequently the directions of diffracted rays change continuously, and the two beams emerge as warped wave fronts \( w''_1 \) and \( w''_2 \). They interfere to generate contours of their separation \( S \), and this interference pattern is recorded by the camera. With the camera focused on the plane of the specimen, the image is the moiré pattern – the map that depicts the in-plane deformation of the specimen. Summing up, moiré interferometry is a case of two-beam interferometry.
It is important to focus the camera on the plane of the specimen. Since wave front warpage changes as the wave travels away from the specimen, it is especially important for cases of strong strain gradients and the concomitant strong warpage of the emerging wave fronts. The issue is addressed in [1.4].

1.2.2 Theoretical Limit

From (1.2), we see that the theoretical upper limit for the reference grating frequency is approached as \( \alpha \) (Fig. 1.6) approaches 90\(^\circ\). The theoretical limit is \( f = 2/\lambda \). The corresponding theoretical upper limit of sensitivity is \( 2/\lambda \) fringes per unit displacement, which corresponds to a contour interval of \( \lambda/2 \) displacement per fringe order.

In the experiment of Fig. 1.1, \( \alpha \) was 77.4\(^\circ\) and \( \lambda = 488.0 \) nm. This produced a virtual reference grating of 4000 lines/mm (101 600 lines/in). For this wavelength, the theoretical limit is \( f = 4098 \) lines/mm, which means that the experiment was conducted at 97.6\% of the theoretical limit of sensitivity.

The theoretical limit pertains to virtual reference gratings formed in air. In the experimental arrangement described later for microscopic moiré interferometry, the grating is formed in a refractive medium.

1.2.3 Black Holes

Referring to Fig. 1.9, we can visualize that the angles of diffraction from any region of the specimen stems from two effects: (1) the load-induced strain and (2) the load-induced surface slope. If the angles of diffraction become large enough, light from that region can miss the lens and never enter the camera. The region appears black in the image – it is called a black hole.

In such cases, the main cause is usually the surface slope. It is rare that a homogeneous body would exhibit large slopes. A composite body, fabricated by joining two dissimilar materials, can exhibit large slopes near the interface as a result of a Poisson’s ratio mismatch. Experience indicates that the slopes are seldom severe enough to cause black regions until very high strain levels are reached.

The camera lens can be translated laterally to capture the light of the moiré pattern that is otherwise lost. In doing so, it is possible that other regions will become black. An alternative is to replace the camera lens with a lens of larger numerical aperture, and this might necessitate viewing the specimen at higher magnification.

1.2.4 Insensitive to Out-of-Plane Deformation

This is largely a pedagogical issue, inasmuch as the literature may not be sufficiently clear. Various publications show sensitivity to out-of-plane rotations. However, the rigorous mathematical analysis of [1.4] proves that moiré interferometry is insensitive to all out-of-plane motions, including rotations. Where do the publications deviate?

Figure 1.10 should help clarify the issue. It represents the planes, or walls of interference of the virtual reference grating, and it also represents the plane of the undeformed specimen grating as plane \( abcd \). Let \( P \) be a point fixed on the specimen grating, and let \( P \) move to another point in space, \( P' \), when the specimen is deformed. The deformed surface surrounding \( P' \) might have any slope, as indicated by the dashed box. As the point moves in the \( x \)-direction, it cuts through walls of interference and therefore causes a change of fringe order in the moiré pattern. Expressed in other words, the point crosses lines of the (virtual) reference grating. For displacement components \( V \) and \( W \), the point does not cross any wall, and therefore these components have no effect on the fringe order. The moiré pattern remains insensitive to \( V \) and \( W \) regardless of the surface slope. This corroborates the proof that moiré interferometry senses only the component of displacement perpendicular to the walls of the virtual reference grating.

Fig. 1.10 Walls of interference of the virtual reference grating. Only the \( U \) component of displacement crosses the walls of the reference grating.
Engineering strain is the ratio of the local change of length to the original length, when both are projected onto the original specimen surface \( abcd \). Thus, engineering strains are correctly determined by (1.4) and (1.5), regardless of surface slopes. Note that out-of-plane displacements are referenced to the original surface, too.

**Fig. 1.11** Displacement fields for a compact shear specimen. Carrier fringes of rotation transform the \( V \) field. Local irregularities in the fringes are caused by local variations in the composite material. (Courtesy of P. G. Ifju)
For exceptional studies in which the surface slope is large enough, the investigator might be interested in these lengths measured on the specimen surface instead of plane $abcd$. This is where the publications deviate. In such cases, a mathematical transformation is required which involves additional variables, specifically the components of the surface slopes. These slopes must be measured (or otherwise determined) to augment the moiré data at each point where the strain is to be calculated. Thus, if the investigator feels the out-of-plane slopes are significant enough to degrade the accuracy that is sought for a specific analysis, then a Lagrangian strain or other three-dimensional strain should be calculated. Otherwise, the investigator accepts that the influence of the slope is negligible for calculating the strain.

Note, too, that special apparatus and procedures may be required to record an image of the moiré fringes when surface slopes become large. Otherwise, the moiré pattern may display black holes in regions of large slopes. In general, it is the engineering strain that is sought by moiré interferometry, not a transformed strain, and (1.4) shows that the normal strain that corresponds to an apparent compressive strain $\varepsilon_{app}$, where

$$\varepsilon_{app} = -\frac{\Psi^2}{2}$$  \hspace{1cm} (1.7)

provided the rotation $\Psi$ is not large. The superscript signifies an extraneous strain, or error. The extraneous fringe gradient is a second-order effect and it can be neglected in the usual case where it is small compared to the strain-induced fringe gradient. Otherwise, a correction can be applied [1.4].

### 1.2.6 Carrier Fringes

An array of uniformly spaced fringes can be produced by adjustment of the moiré interferometer and these are called **carrier fringes**. With the specimen in the no-load condition, a carrier of extension is produced by changing angle $\alpha$ (Fig. 1.6). These fringes are parallel to the lines of the reference grating, just like the fringes of a pure tensile (or compression) specimen. Carrier fringes of rotation are produced by a rigid-body rotation of the specimen or the interferometer, and these are perpendicular to the lines of the reference grating.

It is frequently valuable to modify the load-induced fringe patterns with carrier fringes [1.6]. Figure 1.11 is an example [1.7], where the load-induced fringes are shown in a and b. The specimen is cut from a graphite/epoxy composite material and it is loaded in a compact shear fixture c. In d, the fringes in the test section between notches are subtracted off by carrier fringes of rotation. The carrier fringes are vertical and uniformly spaced, and their gradient is opposite to that of the shear-induced fringes. What is the benefit? It shows that the normal strain $\varepsilon_y$ is zero along the vertical center line of the specimen, that $\varepsilon_y$ is extremely small throughout the test zone, and that the shear deformation is nearly uniform over a wide test region.

Carrier fringes can be introduced easily, typically by turning an adjusting screw in the moiré interferometer. They are used, as needed, for a variety of purposes, especially to remove ambiguities and enhance the accuracy of data reduction.

For in-plane rigid-body rotation

$$\frac{\partial N_x}{\partial y} = -\frac{\partial N_y}{\partial x}.$$  \hspace{1cm} (1.8)

Substitution into (1.5) shows that shear strains calculated from the moiré fringes are not affected by carrier fringes of rotation (when a 4-beam moiré interferometer is used). Also, the calculated shear strains are not affected by carrier fringes of extension. The calculated normal strains are (essentially) unaffected by carrier fringes of rotation. These conditions allow beneficial changes in the fringe patterns without altering the reliability of strain calculations.

### 1.2.7 Loading: Mechanical, Thermal, etc.

Experimental arrangements for mechanical loading are very diverse; they depend upon the size and nature of the specimen and the magnitude of the loads. In some cases it is necessary to mount the moiré interferometer
on the structure of the testing machine, or to attach it to the assembly being investigated. In others, the specimen can be loaded in a fixture that rests on an optical table together with the moiré interferometer.

For real-time thermal loading, or for deformation caused by changes of moisture content, chemical activity or radioactivity, the environmental chamber must be positioned adjacent to the moiré interferometer. Figure 1.12 illustrates a scheme used for thermal deformation measurements in the electronic packaging industry. As an important factor, the specimen is connected rigidly to the interferometer. The connecting rods do not contact the chamber (only loose insulation or compliant baffles fill the air gap at the chamber wall), so vibrations in the forced convection chamber are not transmitted to the specimen. The arrangement has proved to be very effective. It enables the recording of fringe patterns during the transition between temperature changes, during moisture ingress and egress, during chemical activity, etc. Hence, it enables real-time measurements.

Figure 1.13 is an example of real-time thermo-mechanical analysis of an electronic package during a thermal cycle with temperature extremes from $-20^\circ$C to $125^\circ$C [1.8, 9]. The device is an assembly of diverse materials with different coefficients of thermal expansion, so thermal stresses, strains and deformation result from any change of temperature.

The fringes are remarkably clear at this magnification, except for those in the printed circuit board (PCB) at $125^\circ$C; the PCB is a heterogeneous material – a composite of woven glass fibers in an epoxy matrix – and because of the weave its displacement contours are very complicated. Higher magnification is indicated. Visual inspection of the $V$ field shows opposite directions of curvature in the chip region before and after the $125^\circ$C temperature; this behavior results from creep of the solder and molding compound. Whereas extensive computational analysis is undertaken for the mechanical design of electronic packages, the complexities of geometry and materials necessitate experimental guidance and verification.

### 1.2.8 Bithermal Loading

Thermal deformations can also be analyzed by room temperature observations. In this technique, the specimen grating is applied at an elevated temperature, and then the specimen is allowed to cool to room temperature before it is observed in the moiré interferometer. Thus, the deformation incurred by the temperature increment is locked into the grating and recorded at room temperature.

An adhesive that cures slowly at elevated temperature is used, usually an epoxy. The specimen and mold are preheated to the application temperature; then the adhesive is applied, the mold is installed, the adhesive is allowed to cure, and the mold is removed – all at the elevated temperature. The mold is a grating on a zero-expansion substrate, so its frequency is the same at elevated and room temperatures. Otherwise, a correction is required for the thermal expansion of the mold.

These measurements can also be performed at cryogenic temperatures. In one test, the specimen grating was applied at $-40^\circ$C using an adhesive that cured in ultraviolet light.

The example shown in Fig. 1.14 is taken from an investigation of thermal stresses in a bimaterial joint [1.10]. The specimen grating was applied and cured at $157^\circ$C and subsequently observed at $24^\circ$C room temperature. The two materials restrained the natural contraction of each other, causing large thermal stresses and strains. The $V$ displacement field for the $133^\circ$C temperature increment is shown here; carrier fringes of extension were applied to portray the abrupt transition near the interface. Clearly, the fringe gradient $\Delta N_y/\Delta y$ is negative in the brass and positive in the steel. Strains were extracted, and since the elastic constants were known, stresses were calculated. A remarkable condition was found near the interface, namely a peak compressive stress in the brass and a peak tensile stress in the steel. Subsequent analysis by microscopic moiré interferometry documented a severe stress gradient in the...
Fig. 1.13  $U$ and $V$ displacement fields for an electronic package subjected to a thermal cycle in an environmental chamber. $f = 2400$ lines/mm
Fig. 1.14 Thermal deformation for a bimaterial joint. The $N_\theta$ pattern, with carrier fringes of extension, shows the abrupt transition near the interface. $\Delta T = 133^\circ C; a = 55.9 \text{ mm}; f = 2400 \text{ lines/mm}$. 
(Courtesy of J. D. Wood)

50 $\mu$m zone surrounding the interface. The peak stresses were elastic and the peaks were connected by the severe gradient in the transition zone.

1.2.9 Curved Surfaces

Moiré interferometry has been developed for routine analysis of flat surfaces. However, certain accommodations can be made for curved surfaces when the problem is important enough to invest extra effort. The most straightforward approach is to treat any local region as a flat surface. A small grating mold (cut from a larger mold) could be used to replicate the grating on the curved surface of the specimen. Other innovative techniques can be employed for cylindrical surfaces, or other developable surfaces.

Results shown in Fig. 1.15 are from an important investigation. It is from a study of the ply-by-ply deformation at a central hole in multi-ply composite plates [1.11]. The specimens were thick laminated composite plates, each with a 25.4 mm diameter central hole. The grating was applied to the cylindrical surface of the hole and successive replicas of the deformed grating were made with the specimen at different tensile load levels. First, a cross-line grating was formed on the cylindrical surface of a disk and it was used as a mold to apply the grating to the specimen. Then, with the specimen under load, the deformed grating was replicated (or copied) on another disk. The replica was inserted in a moiré interferometer and deformation data were recorded by a moiré interferometer as a series of narrow strips, each approximating a flat surface. Figure 1.15 shows a mosaic of such strips for a 90° portion of the hole in a cross-ply [$0_4/90_3$/S] laminate of IM7/5250-4 (graphite fibers in a bismalimide-cyanate ester matrix). An enlarged view of the $N_\theta$ fringe pattern at the $\theta = 75^\circ$ location is shown in Fig. 1.15d, together with a graph of the ply-by-ply distribution of shear strains. This is the location of greatest fringe density, and yet the data are revealed with excellent fidelity, enabling dependable determination of strain distributions. The interlaminar shear strains at the 0/90 interfaces are about five times greater than the tensile strain at $\theta = 90^\circ$. A primary purpose of the work was to provide experimental data for the evaluation of computational techniques for composite structures.

1.2.10 Data Enhancement/Phase Stepping

An abundance of load-induced fringes is typical for most applications, sufficient for reliable analyses. For small specimens, however, or within a small field of view for larger specimens, the displacement accumulated across the field will be small (even if the strains are not small); then, the number of fringes is not sufficient and additional data are desired.

Phase stepping, also called fringe shifting, provides additional data. Referring to Fig. 1.9, we recall that the fringe pattern is a contour map of the separation $S$ of wave fronts that emerge from the specimen. In phase stepping, the separation $S$ is increased (or decreased) by a fraction of a wavelength, uniformly across the field. The result is a uniform change of fringe order throughout the field of view; the intensity at every pixel, as measured by the digital camera, is changed. Usually, the phase change is accomplished by translating a mirror, or other optical element in the moiré interferometer, using a piezo-electric actuator to displace the element by...
Fig. 1.15a–d
Ply-by-ply displacements at the cylindrical surface of a hole in a cross-ply composite plate. (d) shows an enlarged view of the $U_0$ pattern at the 75° location, and the shear strains at that location. (Courtesy of D. H. Mollenhauer)
Fig. 1.16 Steps in the optical/digital fringe multiplication (O/DFM) algorithm

A lesser known algorithm, called the optical/digital fringe multiplication (O/DFM) method, has also been used for moiré interferometry [1.4]. It shares numerous
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1.2 Important Concepts

Fig. 1.18  Boron/aluminium composite subjected to a change of temperature of 110 °C. Microscopic moiré interferometry was used with \( f = 4800 \text{ lines/mm} \) and \( \beta = 6 \); 35 nm/contour

features with the quasi-heterodyne method, including insensitivity to nonuniform illumination and optical noise. It offers a unique feature, however, because the data that is used comes exclusively from the points in the fringe pattern where the intensity is changing most rapidly. Compared to data taken at (or near) the maximum and minimum intensity points in the fringe pattern, the phase increment per grey level of the CCD camera is many times smaller (approx. 1:50), so the data of greatest accuracy is used exclusively.

The algorithm is portrayed in Fig. 1.16 for multiplication by 2. Two fringe patterns are used, patterns stepped by 0 and by \( \pi \) (i.e., two complementary patterns). Their intensities at each pixel are subtracted, truncated and binarized. The result is a contour map of the fringe orders, with two contours per fringe. Multiplication by 4 is obtained using data stepped by 0, \( \pi/2 \), \( \pi \) and \( 3\pi/2 \). Multiplication by \( \beta \) requires \( \beta \) stepped fringe patterns. Multiplication by \( \beta = 12 \) has been demonstrated.

Fig. 1.19  Microscopic moiré fringe contours for a solder ball interconnection in an electronic package. \( \Delta T = 60 \text{ °C} \); \( f = 4800 \text{ lines/mm} \); \( \beta = 4 \); 52 nm/contour
1.3 Challenges

The authors visualize two developments that would be important contributions to the experimental mechanics community. We propose that members of the community, worldwide, start modest endeavors to develop these capabilities. The first would enhance the ease and accuracy of strain determinations. The second would further enhance the versatility of moiré interferometry.

1.3.1 Strain Analysis

For most macromechanics analyses, moiré interferometry provides a great number of stress-induced fringes, sufficient for a detailed analysis. Yet, in current practice, there is a tendency to use phase-stepping schemes to reduce these data to graphs of displacements and strain distributions. The phase-stepping algorithms enjoy popularity mostly because they enable automatic data reduction. However, there are many pitfalls. Automated analyses do not recognize extraneous input like those from scratches or other imperfections of the specimen grating. Automated analyses do not cope well with rapidly changing displacement fields, for example, those that can be encountered in composite structures; particularly, automated analyses must not be allowed to extend across regions of dissimilar materials.

Thus, for the majority of applications, interactive schemes should be developed in which the investigator controls the process and makes the decisions. The moiré pattern is itself a map of deformation. The investigator should choose the regions of interest – usually the regions where the fringes are closest together and strains are highest. Techniques should be developed to extract these strains with the highest accuracy. The investigator should deal with possible imperfections in the fringe patterns. He/she should decide whether carrier fringes would aid the analysis.

The authors have proposed ideas on methods to explore and perfect. The challenge is published by the Society for Experimental Mechanics in Experimental Techniques [1.14], where the worldwide community is invited to participate. The objective is to devise and share a superior technique for extracting strains, and in an ongoing evolution to improve and refine the technique into an easy, accurate and efficient algorithm. The Society will maintain an open website to share the contributions and make them available to everyone.

1.3.2 Replication of Deformed Gratings

In a classical paper by McKelvie and Walker [1.15], replication was advocated for remote sites and harsh en-
environments, followed by analysis of the replicas in the laboratory. Now, replication is envisioned as a routine practice. In this practice, a grating is applied to the specimen or workpiece in the usual way. Then, the workpiece is subjected to its working loads, for example in a mechanical testing machine, which deforms the specimen and the specimen grating. Replicas of the deformed grating are made at desired intervals in the loading process, and subsequently the replicas are analyzed in a moiré interferometer.

Replication provides numerous advantages for typical applications. No limits are applied to the size of the workpiece. Familiar equipment can be used for loading, including large or special purpose machines. Vibrations and air currents become inconsequential. The technique can be applied in the field, far from the laboratory, and in difficult environments. In many applications, replicas can be made for cases where the loading is not mechanical, but stems from changes of temperature, humidity, chemical or radiation environments, etc.

The replicas can be made on transparent substrates, enabling use of transmission systems of moiré interferometry instead of the current reflection systems. When transmission systems are used, the camera lens can be located very close to the replica and, therefore, high magnifications and high spatial resolution become convenient. Additionally, the replicas become permanent records of the deformation, so there is easy recourse to checking and extending an analysis after an initial investigation.

Thus, replication is extremely attractive for routine use as well as special applications. What developments are required? Although the replication method can be practiced with current technology (Fig. 1.15 is a compelling example) it would be advantageous to find materials and techniques for quick and routine replication of deformed gratings. We believe these techniques will be optimized and broadly implemented; the experimental mechanics community is invited and encouraged to participate in their development.

1.4 Characterization of Moiré Interferometry

The preceding description and examples lead to these conclusions. Moiré interferometry combines the simplicity of geometrical moiré with the high sensitivity of optical interferometry. It measures in-plane displacements with very high sensitivity. Because of the great abundance of displacement data, reliable strain distributions — normal strains and shear strains — can be extracted from the patterns. With knowledge of the material properties, local and global stresses can be determined.

Moiré interferometry is characterized by a list of excellent qualities, including these:

- full-field technique — quantitative measurements can be made throughout the field
- high sensitivity to in-plane displacements \( U \) and \( V \) — typically 0.417 \( \mu \)m per fringe order, but extended into the nanometer range by microscopic moiré interferometry
- insensitive to out-of-plane displacements \( W \) — out-of-plane deformation does not affect the accuracy of in-plane displacement measurements
- high spatial resolution — measurements can be made in tiny zones
- high contrast — the fringe patterns have excellent visibility
- large dynamic range — the method is compatible with large and small displacements, large and small strains, and large and small strain gradients; there are no correlation requirements
- shear strains are determined as accurately as normal strains
- real-time technique — the displacement fields can be viewed as the loads are applied.

Moiré interferometry differs from classical interferometry and holographic interferometry, which are most effective for measuring out-of-plane displacements. It is distinguished from the various methods of speckle interferometry for measuring in-plane displacements, which cannot exhibit the fringe visibility and extensive dynamic range of moiré interferometry. Moiré interferometry has a proven record of applications in engineering and science.

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